Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10561830	HAYASHI ET AL.
Examiner	Art Unit

1795

Thompson-Rummel, Ponder N

SEARCHED	SE	AF	CH	ΗE	D
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Class	Subclass	Date	Examiner
430	270.1,921,910, 326, 322	8/28/2007	PTR
562	45	8/28/2007	PTR
525	337	7/8/2008 and	PTR
		7/10/2008	

SEARCH NOTES

Search Notes	Date	Examiner
Inventorship Search in eDan	8/28/2007	PTR
Reviewed application 10/467130	8/28/2007	PTR
Text search in EAST (see search history printout)	8/28/2007	PTR
Updated Text search in EAST (see search history printout)	7/8/2008 and	PTR
	7/10/2008	

	INTERFERENCE SEAR	СН	
Class	Subclass	Date	Examiner

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